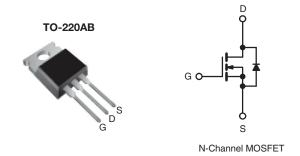


Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	500				
$R_{DS(on)}(\Omega)$	V _{GS} = 10 V	1.4			
Q _g (Max.) (nC)	24				
Q _{gs} (nC)	6.3				
Q _{gd} (nC)	11				
Configuration	Single				



FEATURES

• Low Gate Charge Qq Results in Simple Drive



 Improved Gate, Avalanche and Dynamic dV/dt RoHS Ruggedness

- Fully Characterized Capacitance and Avalanche Voltage and Current
- Effective Coss Specified
- Compliant to RoHS Directive 2002/95/EC

APPLICATIONS

- Switch Mode Power Supply (SMPS)
- Uninterruptable Power Supply
- High Speed power Switching

TYPICAL SMPS TOPOLOGIES

- Two Transistor Forward
- Half Bridge
- Full Bridge

ORDERING INFORMATION	
Package	TO-220AB
Lead (Pb)-free	IRF830APbF
Leau (FD)-iree	SiHF830A-E3
SnPb	IRF830A
SIIFU	SiHF830A

ABSOLUTE MAXIMUM RATINGS (T _C	= 25 °C, unl	ess otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	500	V	
Gate-Source Voltage			V_{GS}	± 30	7	
Continuous Drain Current	T _C = 25 °C		5.0			
Continuous Drain Current	V _{GS} at 10 V	$T_C = 25 \degree C$ $T_C = 100 \degree C$	I _D	3.2	Α	
Pulsed Drain Current ^a			I _{DM}	20		
Linear Derating Factor				0.59	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	230	mJ	
Repetitive Avalanche Current ^a			I _{AR}	5.0	А	
Repetitive Avalanche Energy ^a			E _{AR}	7.4	mJ	
Maximum Power Dissipation $T_C = 25 ^{\circ}C$			P_{D}	74	W	
Peak Diode Recovery dV/dt ^c			dV/dt	5.3	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature) for 10 s				300 ^d		
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Torque			-	1.1	N⋅m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Starting T_J = 25 °C, L = 18 mH, R_g = 25 Ω , I_{AS} = 5.0 A (see fig. 12). c. I_{SD} \leq 5.0 A, dI/dt \leq 370 A/µs, V_{DD} \leq V_{DS}, T_J \leq 150 °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient	R _{thJA}	-	62			
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	°C/W		
Maximum Junction-to-Case (Drain)	R _{thJC}	-	1.7			

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I _D = 1 mA	-	0.60	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	V_{GS} , $I_D = 250 \mu A$	2.0	-	4.5	V
Gate-Source Leakage	I _{GSS}	\	$I_{GS} = \pm 30 \text{ V}$	-	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}		500 V, V _{GS} = 0 V	-	-	25	μΑ
-		+	$V_{GS} = 0 \text{ V}, T_{J} = 125 \text{ °C}$	-	-	250	,
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	$I_D = 3.0 \text{ A}^b$	-	-	1.4	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	50 V, $I_D = 3.0 A^b$	2.8	-	-	S
Dynamic					ı	_	T
Input Capacitance	C _{iss}		$V_{GS} = 0 V$,	-	620	-]
Output Capacitance	C _{oss}	V _{DS} = 25 V,		-	93	-	
Reverse Transfer Capacitance	C_{rss}	f = 1.0 MHz, see fig. 5		-	4.3	-	pF
Output Capacitance	C_{oss}	V _{GS} = 0 V; V _{DS} = 1.0 V, f = 1.0 MHz			886		pr
Output Capacitance	C_{oss}	V _{GS} = 0 V; V _{DS} = 400 V, f = 1.0 MHz			27		
Effective Output Capacitance	Coss eff.	V _{GS} = 0 V; V _{DS} = 0 V to 400 V ^c			39		
Total Gate Charge	Q_g		$V_{GS} = 10 \text{ V}$ $I_D = 5.0 \text{ A}, V_{DS} = 400 \text{ V},$ see fig. 6 and 13b		-	24	nC
Gate-Source Charge	Q_gs	V _{GS} = 10 V			-	6.3	
Gate-Drain Charge	Q_{gd}		see lig. 6 and 15°	-	-	11	
Turn-On Delay Time	t _{d(on)}			-	10	-	
Rise Time	t _r	$V_{DD} =$	250 V, I _D = 5.0 A,	-	21	-	
Turn-Off Delay Time	t _{d(off)}	$R_0 = 14 \Omega$	$R_{\rm q} = 14 \ \Omega, \ R_{\rm D} = 49 \ \Omega, \ {\rm see \ fig. \ } 10^{\rm b}$		21	-	- ns
Fall Time	t _f			-	15	-	
Drain-Source Body Diode Characteristic	cs						
Continuous Source-Drain Diode Current	Is	MOSFET symbol showing the integral reverse p - n junction diode		-	-	5.0	
Pulsed Diode Forward Current ^a	I _{SM}			-	-	20	A
Body Diode Voltage	V_{SD}	T _J = 25 °C,	T _J = 25 °C, I _S = 5.0 A, V _{GS} = 0 V ^b		-	1.5	V
Body Diode Reverse Recovery Time	t _{rr}	$T_J = 25 \text{ °C}, I_F = 5.0 \text{ A}, dI/dt = 100 \text{ A/}\mu\text{s}^b$		-	430	650	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	1.62	2.4	μC
Forward Turn-On Time	t _{on}	Intrinsic to	urn-on is	dominated	by Le and	d Ln)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 µs; duty cycle \leq 2 %.
- c. C_{oss} eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DS} .



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

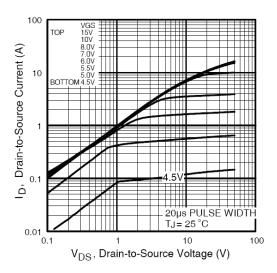


Fig. 1 - Typical Output Characteristics

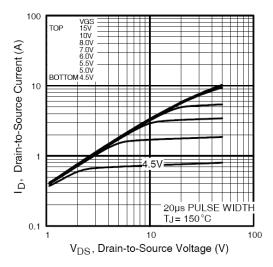


Fig. 2 - Typical Output Characteristics

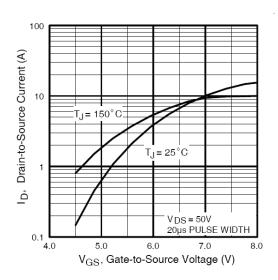


Fig. 3 - Typical Transfer Characteristics

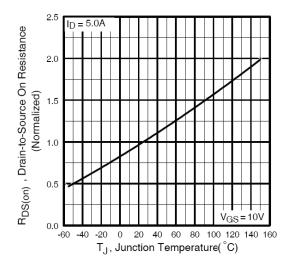


Fig. 4 - Normalized On-Resistance vs. Temperature



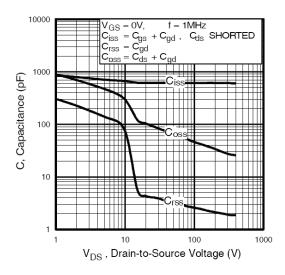


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

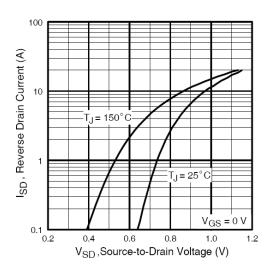


Fig. 7 - Typical Source-Drain Diode Forward Voltage

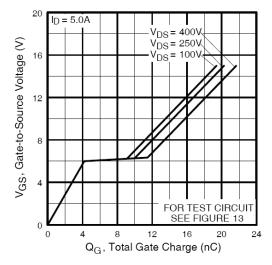


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

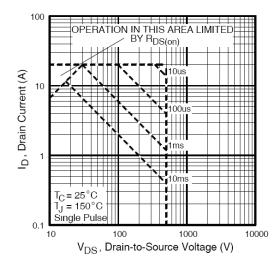


Fig. 8 - Maximum Safe Operating Area



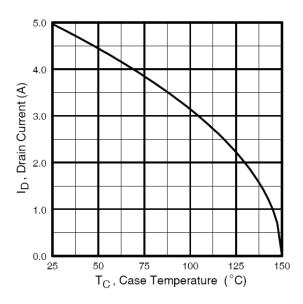


Fig. 9 - Maximum Drain Current vs. Case Temperature

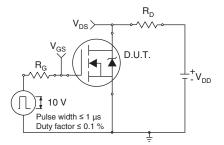


Fig. 10a - Switching Time Test Circuit

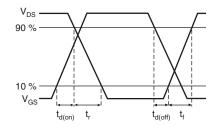


Fig. 10b - Switching Time Waveforms

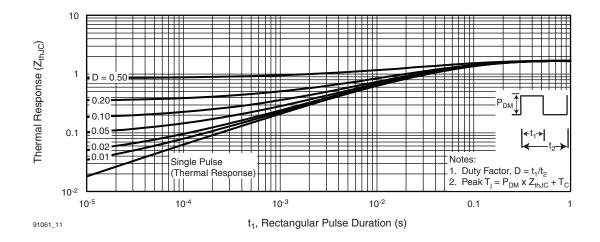


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



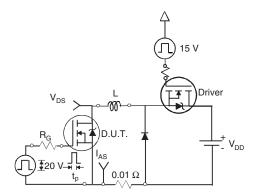


Fig. 12a - Unclamped Inductive Test Circuit

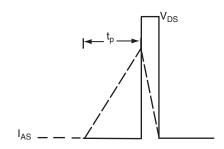


Fig. 12b - Unclamped Inductive Waveforms

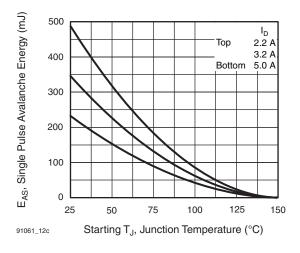


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

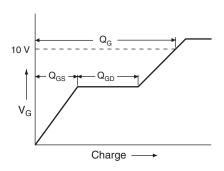


Fig. 12d - Basic Gate Charge Waveform

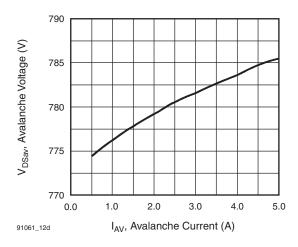


Fig. 13a - Typical Drain-to-Source Voltage vs. Avalanche Current

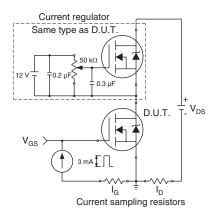
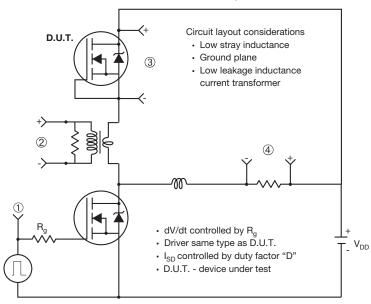


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



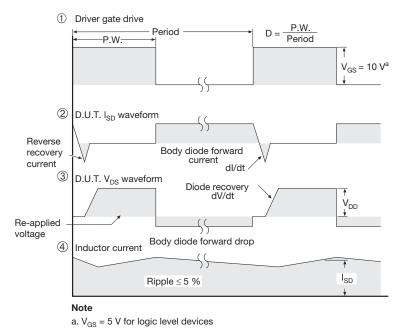


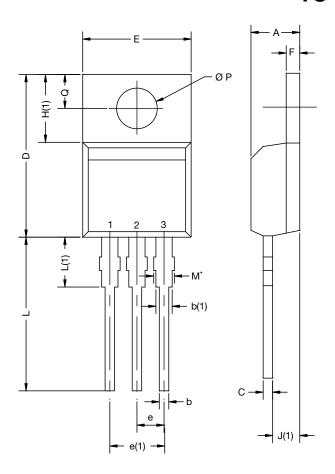
Fig. 14 - For N-Channel

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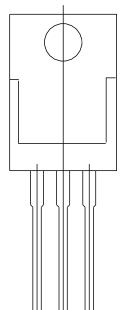
TO-220-1



	MILLIN	IETERS	INC	HES	
DIM.	MIN.	MAX.	MIN.	MAX.	
Α	4.14	4.70	0.163	0.185	
b	0.69	1.02	0.027	0.040	
b(1)	1.14	1.73	0.045	0.068	
С	0.36	0.61	0.014	0.024	
D	14.33	15.85	0.564	0.624	
Е	9.96	10.52	0.392	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	0.43	1.40	0.017	0.055	
H(1)	6.10	6.48	0.240	0.255	
J(1)	2.41	2.92	0.095	0.115	
L	13.36	14.40	0.526	0.567	
L(1)	3.33	4.04	0.131	0.159	
ØΡ	3.53	3.94	0.139	0.155	
Q	2.59	3.00	0.102	0.118	
ECN: X15-0003-Rev. A, 19-Jan-15 DWG: 6031					

Notes

- M* = 0.052 inches to 0.064 inches (dimension including protrusion), heatsink hole for HVM
- Outline conforms to JEDEC[®] outline TO-220AB with exception of dimension F



Revison: 19-Jan-15 1 Document Number: 66542



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Revision: 02-Oct-12 Document Number: 91000

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